

## Special Issue

# Fault Detection Technology Based on Deep Learning

### Message from the Guest Editors

In recent years, there has been increasing interest in and investment on electrical-based systems in various applications. Such systems should have high performance, reliability, and availability. Indeed, they are exposed to several types of failures due to external and internal sources. Failures may affect energy sources, actuators, sensors, or controllers. Consequently, predictive maintenance based on accurate fault diagnosis approaches and fault-tolerant control strategies is of upmost importance. State-of-the-art reviews have shown that fault diagnosis methods are mainly classified in model-based approaches and signal-based approaches. However, with the increase in data acquisition and processing algorithms, artificial intelligence (AI) tools have become more attractive for fault diagnosis and fault classification issues. Indeed, AI approaches are only based on recorded data obtained from measured quantities instead of specific complex mathematical models. The main purpose of this Special Issue is to share high-quality original research articles and reviews in the area of fault diagnosis based on deep learning and its applications.

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### Guest Editors

Dr. Séjir Khojet El Khil

Dr. Chiara Boccaletti

Dr. Monia Ben Khader Bouzid

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### Deadline for manuscript submissions

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## Electronics

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## About the Journal

### Message from the Editor-in-Chief

*Electronics* is a multidisciplinary journal designed to appeal to a diverse audience of research scientists, practitioners, and developers in academia and industry. The journal is devoted to fast publication of latest technological breakthroughs, cutting-edge developments, and timely reviews of current and emerging technologies related to the broad field of electronics. Experimental and theoretical results are published as regular peer-reviewed articles or as articles within Special Issues guest-edited by leading experts in selected topics of interest.

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### Editor-in-Chief

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